

<b>Notice of References Cited</b>		Application/Control No. 10/522,270	Applicant(s)/Patent Under Reexamination LIEBHOLD ET AL.	
		Examiner Nnenna N. Ekpo	Art Unit 2623	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,446,080	09-2002	Van Ryzin et al.	707/104.1
*	B	US-2003/0023975	01-2003	Schrader et al.	725/51
*	C	US-2004/0148419	07-2004	Chen et al.	709/231
*	D	US-6,721,489	04-2004	Benyamin et al.	386/46
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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